

Test report No. : 12717479H-B-R2
Page : 1 of 16
Issued date : May 27, 2019
FCC ID : WAZSKESAD01

EMI TEST REPORT

Test Report No.: 12717479H-B-R2

Applicant : Mitsubishi Electric Corporation Himeji works

Type of Equipment : Smart Keyless System Smart Unit

Model No. : SKESAD-01

FCC ID : WAZSKESAD01

Test regulation : FCC Part 15 Subpart B: 2018 Class B

Test Result : Complied (Refer to SECTION 3.2)

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.

- 2. The results in this report apply only to the sample tested.
- 3. This sample tested is in compliance with the above regulation.
- 4. The test results in this report are traceable to the national or international standards.
- 5. This test report covers EMC technical requirements. It does not cover administrative issues such as Manual or non-EMC test related Requirements. (if applicable)
- 6. The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
- 7. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
- 8. The information provided from the customer for this report is identified in SECTION 1.
- 9. This report is a revised version of 12717479H-B-R1. 12717479H-B-R1 is replaced with this report.

Date of test:

Representative test engineer:

May 22, 2019

Akihiko Maeda

Engineer Consumer Technology Division

Approved by:

Motoya Imura Leader

Consumer Technology Division



This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation. *As for the range of Accreditation in NVLAP, you may refer to the WEB address,

http://japan.ul.com/resources/emc_accredited/

The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.

There is no testing item of "Non-accreditation".

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Test report No. : 12717479H-B-R2
Page : 2 of 16
Issued date : May 27, 2019
FCC ID : WAZSKESAD01

REVISION HISTORY

Original Test Report No.: 12717479H-B

Revision	Test report No.	Date	Page	Contents
			revised	
- (Original)	12717479Н-В	March 14, 2019	-	-
1	12717479H-B-R1	May 24, 2019	<pre><correction retesting="" with=""> Date of test; from February 7, 2019 to May 22, 2019</correction></pre>	
1	12717479H-B-R1	May 24, 2019	P. 5	Correction with retesting> Worst margin; from 18.87 dB, 912.900 MHz, Vertical to 20.05 dB, 945.840 MHz, Horizontal
1	12717479H-B-R1	May 24, 2019	P. 9	<correction retesting="" with=""> Frequency range; from 1000 MHz - 4000 MHz to 1000 MHz - 10000 MHz</correction>
1	12717479H-B-R1	May 24, 2019	P. 9, 10	<pre><correction retesting="" with=""> Distance Factor; from 20 x log (3.65 m / 3 m) = 1.82 dB to 20 x log (3.9 m / 3 m) = 2.28 dB</correction></pre>
1	12717479H-B-R1	May 24, 2019	P. 10	<correction retesting="" with=""> Test Volume; From 1.5 m to 2.0 m</correction>
1	12717479H-B-R1	May 24, 2019	P. 11, 12	<correction retesting="" with=""> Test data</correction>
1	12717479H-B-R1	May 24, 2019	P. 13	<correction retesting="" with=""> Test Instruments</correction>
2	12717479H-B-R2	May 27, 2019	P.12	Correction of CALCULATION for above 1 GHz.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Test report No. : 12717479H-B-R2
Page : 3 of 16
Issued date : May 27, 2019
FCC ID : WAZSKESAD01

CONTENTS PAGE Customer information4 **SECTION 1:** Equipment under test (E.U.T.).....4 **SECTION 2:** Test specification, procedures & results5 **SECTION 3:** Operation of E.U.T. during testing......8 **SECTION 4: SECTION 5: APPENDIX 1:** Test data ______11 Radiated emission 11 Test instruments ______13 **APPENDIX 2: APPENDIX 3:** Radiated Emission14

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Test report No. : 12717479H-B-R2
Page : 4 of 16
Issued date : May 27, 2019
FCC ID : WAZSKESAD01

SECTION 1: Customer information

Company Name : Mitsubishi Electric Corporation Himeji works Address : 840 Chiyoda-machi, Himeji, Hyogo 670-8677, Japan

Telephone Number : +81-79-298-9580 Facsimile Number : +81-79-298-9929 Contact Person : Shinichi Furuta

The information provided from the customer is as follows;

- Applicant, Type of Equipment, Model No. on the cover and other relevant pages
- SECTION 1: Customer information
- SECTION 2: Equipment under test (E.U.T.)
- SECTION 4: Operation of E.U.T. during testing
- * The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Smart Keyless System Smart Unit

Model No. : SKESAD-01

Serial No. : Refer to Section 4, Clause 4.2

Rating : DC 12.0 V Receipt Date of Sample : February 4, 2019

(Information from test lab.)

Country of Mass-production : Japan

Condition of EUT : Engineering prototype

(Not for Sale: This sample is equivalent to mass-produced items.)

Modification of EUT : No Modification by the test lab

2.2 Product Description

Model: SKESAD-01 (referred to as the EUT in this report) is a Smart Keyless System Smart Unit.

Radio Specification

LF Part *

Equipment Type : Transmitter
Type of modulation : ASK
Frequency of operation : 125 kHz
Other clock frequency : -

Antenna Type : Inductive Clock frequency : 8 MHz

RF Part

Type of Receiver : Receiver
Frequency of operation : 315 MHz
Other clock frequency : 30.32 MHz
Intermediate frequency : 280 kHz
Antenna Type : Bar Antenna

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

^{*} The test of transmiter part was performed separately from this test report, and the conformability is confirmed. LF Part test report No. 12717479H-A (FCC15C).

Test report No. : 12717479H-B-R2
Page : 5 of 16
Issued date : May 27, 2019
FCC ID : WAZSKESAD01

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart B

FCC Part 15 final revised on March 12, 2018 and effective April 11, 2018

Title : FCC 47CFR Part15 Radio Frequency Device

Subpart B Unintentional Radiators

3.2 Procedures and results

Item	Test Procedure	Limits	Deviation	Worst margin	Result	Remarks	
Conducted emission	FCC: ANSI C63.4: 2014 7. AC power - line conducted emission measurements	FCC:Part 15 Subpart B 15.107(a)	N/A	N/A	N/A	*1)	
	IC: RSS-Gen 8.8	IC: RSS-Gen 8.8					
Radiated emission	FCC: ANSI C63.4: 2014 8. Radiated emission measurements	FCC: Part 15 Subpart B 15.109(a)	N/A	20.05 dB 945.840 MHz,	Complied a)	-	
•1111551011	IC: RSS-Gen 7	IC: RSS-Gen 7.1.2		Horizontal, QP			

^{*}Note: UL Japan, Inc's EMI Work Procedure 13-EM-W0420.

a) Refer to APPENDIX 1 (data of Radiated emission)

Symbols:

Complied The data of this test item has enough margin, more than the measurement uncertainty.

Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.

3.3 Addition to standard

No addition, exclusion nor deviation has been made from the standard.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

^{*1)} The test is not applicable since the EUT is not the device that is designed to be connected to the public utility (AC) power line.

Test report No. : 12717479H-B-R2
Page : 6 of 16
Issued date : May 27, 2019
FCC ID : WAZSKESAD01

3.4 Uncertainty

There is no applicable rule of uncertainty in this applied standard. Therefore, the following results are derived depending on whether or not laboratory uncertainty is applied.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor k = 2.

Test distance	Radiated emission (+/-)
	9 kHz to 30 MHz
3 m	3.3 dB
10 m	3.2 dB

^{*}Measurement distance

		Radiated emission (Below 1 GHz)										
Polarity	(3 m	*)(+/-)	(10 m*)(+/-)									
	30 MHz to 200 MHz	200 MHz to 1000 MHz	30 MHz to 200 MHz	200 MHz to 1000 MHz								
Horizontal	4.8 dB	5.2 dB	4.8 dB	5.0 dB								
Vertical	5.0 dB	6.3 dB	4.9 dB	5.0 dB								

Radiated emission (Above 1 GHz)											
(3 m ³	*)(+/-)	(1 r	(10 m*)(+/-)								
1 GHz to 6 GHz	6 GHz to 18 GHz	10 GHz to 26.5 GHz	26.5 GHz to 40 GHz	1 GHz to 18 GHz							
5.0 dB	5.3 dB	5.8 dB	5.8 dB	5.2 dB							

^{*} Measurement distance

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Test report No. : 12717479H-B-R2
Page : 7 of 16
Issued date : May 27, 2019
FCC ID : WAZSKESAD01

3.5 Test Location

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN Telephone: +81 596 24 8999, Facsimile: +81 596 24 8124

NVLAP Lab. code: 200572-0 / FCC Test Firm Registration Number: 199967

Test site	IC Registration Width x Depth x Size of reference ground plane (m) Number Height (m) / horizontal conducting plane		Other rooms	Maximum measuremen t distance	
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.6 shielded room	-	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	-	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	_	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	-	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	-	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	-	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

^{*} Size of vertical conducting plane (for Conducted Emission test): $2.0 \text{ m} \times 2.0 \text{ m}$ for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Test report No. : 12717479H-B-R2
Page : 8 of 16
Issued date : May 27, 2019
FCC ID : WAZSKESAD01

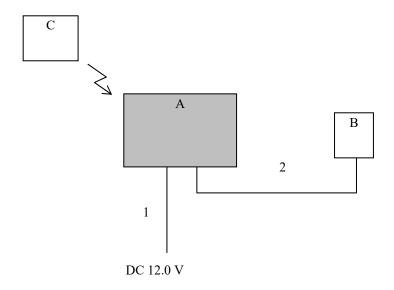
SECTION 4: Operation of E.U.T. during testing

4.1 **Operating Mode(s)**

Mode	Remarks
1) Receiving mode (315 MHz)	-

^{*} It was confirmed by using SW BOX that the EUT receives the signal from the transmitter (pair of EUT).

4.2 Configuration and peripherals



^{*} Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Smart Keyless System	SKESAD-01	20190131-E2	Mitsubishi Electric	EUT
	Smart Unit		(No.2)	Corporation Himeji works	
В	SW BOX	SW BOX2	No.16	Mitsubishi Electric	-
				Corporation Himeji works	
C	Smart Keyless System	SKESAD-02	20190131-T2	Mitsubishi Electric	-
	Hand Unit		(No.2)	Corporation Himeji works	

List of cables used

No.	Name	Length (m)	Shi	Remarks	
			Cable	Connector	
1	DC Cable	1.5	Unshielded	Unshielded	-
2	DC and Signal cable	1.0	Unshielded	Unshielded	(No.1)

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Test report No. : 12717479H-B-R2
Page : 9 of 16
Issued date : May 27, 2019
FCC ID : WAZSKESAD01

SECTION 5: Radiated Emission

5.1. Operating environment

Test place : No.4 semi anechoic chamber

Temperature : See data Humidity : See data

5.2. Test configuration

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The EUT was set on the edge of the tabletop.

Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength.

Photographs of the set up are shown in Appendix 3.

5.3. Test conditions

Frequency range : 30 MHz - 200 MHz (Biconical antenna) / 200 MHz - 1000 MHz (Logperiodic antenna)

1000 MHz - 10000 MHz (Horn antenna)

Test distance : 3 m

EUT position : Table top

EUT operation mode : See Clause 4.1

5.4. Test procedure

The height of the measuring antenna varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver.

The radiated emission measurements were made with the following detector function of the Test Receiver.

Frequency	Below 1GHz	Above 1GHz *1)
Instrument used	Test Receiver	Test Receiver
IF Bandwidth	QP: BW 120 kHz	PK: BW 1 MHz, CISPR AV: BW 1 MHz

^{*1)} The measurement data was adjusted to a 3 m distance using the following Distance Factor. Distance Factor: 20 x log (3.9 m / 3 m) = 2.28 dB

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

 Test report No.
 : 12717479H-B-R2

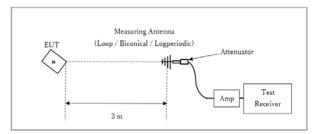
 Page
 : 10 of 16

 Issued date
 : May 27, 2019

 FCC ID
 : WAZSKESAD01

Figure 2: Test Setup

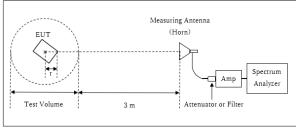
Below 1 GHz



Test Distance: 3 m

× : Center of turn table

1 GHz - 10 GHz



- r : Radius of an outer periphery of EUT
- ×: Center of turn table

Distance Factor: $20 \times \log (3.9 \text{ m}^*/3.0 \text{ m}) = 2.28 \text{ dB}$ * Test Distance: (3 + Test Volume /2) - r = 3.9 m

Test Volume: 2.0 m

(Test Volume has been calibrated based on CISPR 16-1-4.)

r = 0.1 m

- The noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

5.5. Test result

Summary of the test results: Pass

The limit is rounded down to one decimal place.

The test result is rounded off to one or two decimal places, so some differences might be observed.

Date: May 22, 2019 Test engineer: Akihiko Maeda

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Test report No. : 12717479H-B-R2
Page : 11 of 16
Issued date : May 27, 2019
FCC ID : WAZSKESAD01

APPENDIX 1: Test data

Radiated emission

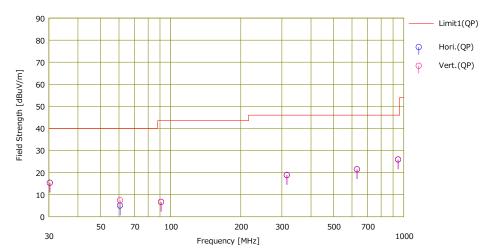
Report No. 12717479H Test place Ise EMC Lab.

Semi Anechoic Chamber No.4

Date May 22, 2019
Temperature / Humidity 25 deg. C / 38 % RH
Engineer Akihiko Maeda
(Below 1 GHz)

Mode 1

Limit: FCC_Part 15 Subpart B(15.109)_Class B



													T
No.	Freq.	Reading (QP)	Ant Fac	Loss	Gain	Result (QP)	Limit (QP)	Margin (QP)	Pola.	Height	Angle	Ant. Type	Comment Comment
	(MHz)	[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[H/V]	[cm]	[deg]	Type	
1	30.320	22.20	18.16	7.20	32.21	15.35	40.00	24.65	Hori.	300	8	BC	
2	60.640	22.00	7.49	7.70	32.15	5.04	40.00	34.96	Hori.	300	352	BC	
3	90.960	22.10	8.60	8.09	32.12	6.67	43.50	36.83	Hori.	300	321	BC	
4	315.280	26.60	14.07	10.05	31.92	18.80	46.00	27.20	Hori.	100	352	LA23	
5	630.560	22.20	19.37	11.95	32.08	21.44	46.00	24,56	Hori.	100	215	LA23	
6	945.840	21.40	21.99	13.45	30.89	25.95	46.00	20.05	Hori.	100	341	LA23	
7	30.320	22.20	18.16	7.20	32.21	15,35	40.00	24.65	Vert.	100	0	BC	
8	60.640	24.40	7.49	7.70	32.15	7.44	40.00	32.56	Vert.	100	259	BC	
9	90.960	22.10	8.60	8.09	32.12	6.67	43.50	36.83	Vert.	100	288	BC	
10	315.280	26.70	14.07	10.05	31.92	18.90	46.00	27.10	Vert.	100	14	LA23	
11	630.560	22.20	19.37	11.95	32.08	21.44	46.00	24.56	Vert.	100	96	LA23	
12	945.840	21.30	21.99	13.45	30.89	25.85	46.00	20.15	Vert.	100	171	LA23	

CHART: WITH FACTOR

ANT TYPE: - 30 MHz: LOOP, 30 MHz - 200 MHz: BICONICAL, 200 MHz - 1000 MHz: LOGPERIODIC, 1000 MHz -: HORN CALCULATION: RESULT = READING + ANT FACTOR + LOSS & GAIN (CABLE + ATT - GAIN(AMP))

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Test report No. : 12717479H-B-R2 Page : 12 of 16 **Issued date** : May 27, 2019 FCC ID : WAZSKESAD01

Radiated emission

12717479H Report No. Test place Ise EMC Lab.

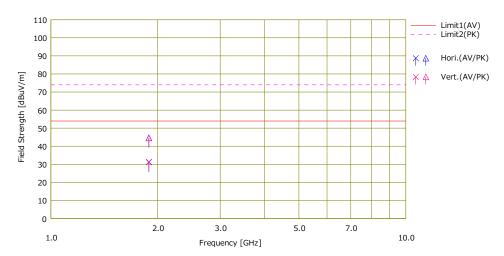
Semi Anechoic Chamber No.4

May 22, 2019 25 deg. C / 38 % RH Temperature / Humidity Akihiko Maeda Engineer

(Above 1 GHz)

Mode 1 Mode

Limit : FCC_Part 15 Subpart B(15.109)_Class B



	_	Rea	ding				Res	sult	Li	nit	Mar	rgin					
No.	Freq.	(AV)	(PK)	Ant Fac	Loss	Gain	(AV)	(PK)	(AV)	(PK)	(AV)	(PK)	Pola.	Height	Angle	Ant. Type	Comment
	[MHz]	[dBuV]	[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dBuV/m]	[dB]	[dB]	[H/V]	[cm]	[deg]	1,400	
1	1888.320	31.50	44.90	25.97	5.49	31.80	31.16	44.56	54.00	74.00	22.84	29.44	Hori.	100	0	H21	
2	1888.320	31.60	45.00	25.97	5.49	31.80	31.26	44.66	54.00	74.00	22.74	29.34	Vert.	100	0	H21	
ll																	
											-						
ll																	
											1						
											-						
											ļ						

CHART: WITH FACTOR

ANT TYPE: - 30 MHz: LOOP, 30 MHz - 200 MHz: BICONICAL, 200 MHz - 1000 MHz: LOGPERIODIC, 1000 MHz -: HORN CALCULATION: RESULT = READING + ANT FACTOR + LOSS & GAIN (CABLE - GAIN(AMP) + D-factor)

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Test report No. : 12717479H-B-R2
Page : 13 of 16
Issued date : May 27, 2019
FCC ID : WAZSKESAD01

APPENDIX 2: Test instruments

Test Instruments

Test item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Calibration Due Date	Cal Int
RE	141425	Biconical Antenna	Schwarzbeck	BBA9106	1302	2018/6/1	2019/6/30	12
RE	141267	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	911B-192	2019/3/21	2020/3/31	12
RE	148898	Attenuator	KEYSIGHT	8491A	MY52462282	2018/10/3	2019/10/31	12
RE	141397	Coaxial Cable	UL Japan	-	-	2018/6/13	2019/6/30	12
RE	141583	Pre Amplifier	SONOMA INSTRUMENT	310	260833	2019/2/8	2020/2/29	12
RE	141949	Test Receiver	Rohde & Schwarz	ESCI	100767	2018/8/6	2019/8/31	12
RE	141581	MicroWave System Amplifier	AGILENT	83017A	650	2018/10/4	2019/10/31	12
RE	141297	High Pass Filter(1.1-10GHz)	TOKYO KEIKI	TF219CD1	1001	2019/1/10	2020/1/31	12
RE	141412	Microwave Cable	Junkosha	MWX221	1305S002R(1m) / 1405S146(5m)	2018/6/14	2019/6/30	12
RE	141508	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	9120D-557	2018/6/8	2019/6/30	12
RE	141902	Spectrum Analyzer	AGILENT	E4440A	MY46187105	2018/10/4	2019/10/31	12
RE	178648	EMI measurement program	TSJ	TEPTO-DV	-	-	-	-
RE	142227	Measure	KOMELON	KMC-36	-	-	-	-
RE	141545	DIGITAL HITESTER	HIOKI	3805	51201148	2019/1/29	2020/1/31	12
RE	142017	AC4_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	2019/4/4	2020/4/30	12
RE	142011	AC4_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	2018/6/28	2020/6/30	24
RE	141562	Thermo-Hygrometer	CUSTOM	CTH-201	10	2019/1/11	2020/1/31	12

^{*}Hyphens for Last Calibration Date, Calibration Due Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test item:

RE: Radiated emission

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN